Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/685,161	BENDER ET AL.
Examiner	**Art Unit**
Allahyar Kasraian	2609

SEARCHED			
Class	Subclass	Date	Examiner
370	474	3/16/2007	AK
370	464	3/16/2007	AK
370	389	3/16/2007	AK

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST Image and keyword search in USPTO, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (see attached seach strategy)	3/16/2007	AK
Inventor name and Assignee search in PALM ExPo and EAST	3/16/2007	AK
((370/474,464,389.ccls.) (709/230-232,236,245.ccls.) (710/1,3,5,30,36,52,56,100,301,305) and (header near5 (assembl$3 or accu	3/16/2007	AK
IEEE Xplorehttp://ieeexplore.ieee.org/Xplore/DynWel.jspGooglehttp://www.google.com	3/16/2007	AK
EPO Data basehttp://ep.espacenet.com	3/16/2007	AK